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SHEET 1 OF 1

Form PTO 1449 (Modified)		U.S. DEPARTMENT (PATENT AND TRAD	OF COMMERCE DEMARK OFFICE	ATTY DOCKET NO. 288708US2PCT	5/		SERIAL NO. 10/574,177	
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INITIAL		NUMBER	DATE	NAME	CLASS	CLASS	IF APPROPRIATE	
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/IA/	AO	1 286 187	2/26/2003	EP			NO	
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	AZ		***************************************		Addi	itional Refer	rences sheet(s) attached	
Examiner		/lyabo Alli/ (10/01/2007)				Date Considered 10/01/2007		
*Examiner In				t citation is in conformance with MPEP 60				
conformance	and no	ot considered. Include or	opy of this form	n with next communication to applicant.	US, Diaw	ile uncogn.	Claudi ii not iii	